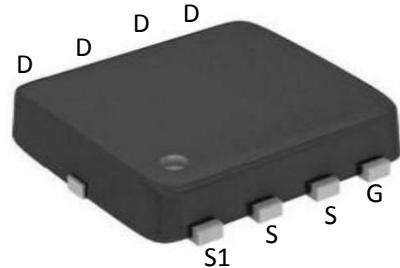


Description:

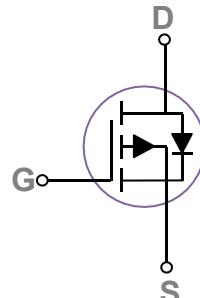
This P-Channel MOSFET uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.



Features:

- 1) $V_{DS}=-30V, I_D=-40A, R_{DS(ON)} < 11m\Omega @ V_{GS}=-10V$
- 2) Low gate charge.
- 3) Green device available.
- 4) Advanced high cell density trench technology for ultra low $R_{DS(ON)}$.

Excellent package for good heat dissipation.



Absolute Maximum Ratings: ($T_C=25^\circ C$ unless otherwise noted)

Symbol	Parameter	Ratings	Units
V_{DS}	Drain-Source Voltage	-30	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Continuous Drain Current- $T_C=25^\circ C$	-40	A
	Continuous Drain Current- $T_C=100^\circ C$	-32	
I_{DM}	Pulsed Drain Current	-200	
P_D	Power Dissipation- $T_C=25^\circ C$	38	W
T_J, T_{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Thermal Characteristics:

Symbol	Parameter	Max	Units
R_{eJC}	Thermal Resistance,Junction to Case	3.3	°C/W
R_{eJA}	Thermal Resistance,Junction to Ambient	55	°C/W

Package Marking and Ordering Information:

Part NO.	Marking	Package
DOZ40P03	40P03	DFN3*3-8

Electrical Characteristics: ($T_C=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0V, I_D=250 \mu\text{A}$	-30	---	---	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS}=0V, V_{DS}=-30V$	---	---	-1	μA
I_{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm 25V, V_{DS}=0A$	---	---	± 100	nA
On Characteristics						
$V_{GS(\text{th})}$	GATE-Source Threshold Voltage	$V_{GS}=V_{DS}, I_D=250 \mu\text{A}$	-1	-1.5	-2.0	V
$R_{DS(\text{ON})}$	Drain-Source On Resistance	$V_{GS}=-10V, I_D=-12A$	---	8.5	11	$\text{m}\Omega$
		$V_{GS}=-4.5V, I_D=-7A$	---	12	15	
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{DS}=-15V, V_{GS}=0V, f=1\text{MHz}$	---	1779	---	pF
C_{oss}	Output Capacitance		---	234	---	
C_{rss}	Reverse Transfer Capacitance		---	199	---	
Switching Characteristics						
$t_{d(on)}$	Turn-On Delay Time	$V_{DD}=-15V, R_L=1\Omega$ $R_{GEN}=3 \Omega, V_{GS}=-10V,$	---	7	---	ns
t_r	Rise Time		---	26	---	ns
$t_{d(off)}$	Turn-Off Delay Time		---	68	---	ns
t_f	Fall Time		---	39	---	ns
Q_g	Total Gate Charge	$V_{GS}=-10V, V_{DS}=-15V,$ $I_D=-15A$	---	45	---	nC
Q_{gs}	Gate-Source Charge		---	1	---	nC
Q_{gd}	Gate-Drain "Miller" Charge		---	1	---	nC
Drain-Source Diode Characteristics						
V_{SD}	Diode Forward Voltage	$V_{GS}=0V, I_S=-1A$	---	-0.7	-1	V
I_S	Diode Forward Current	$V_D=V_G=0V$	---	---	-40	A

I_{sm}	Pulsed Source Current	V _D =V _G =0V	---	---	-200	A
T_{rr}	Reverse Recovery Time	I _s =-4A ,dI/dt=100A/μs V _{GS} =0V	---	13.5	---	ns
Q_{rr}	Reverse Recovery Charge		---	3.7	---	nC

Typical Characteristics: (T_c=25°C unless otherwise noted)

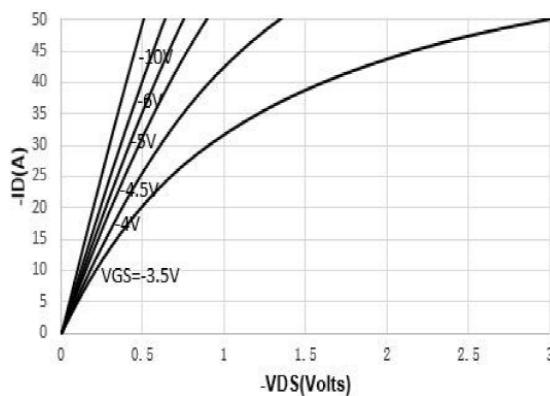


Figure 1. On-Region Characteristics

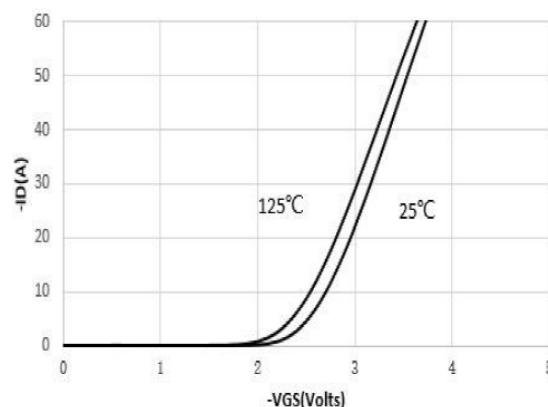


Figure 2. Transfer Characteristics

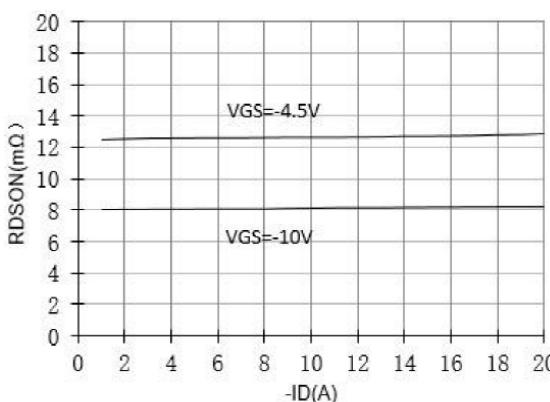


Figure 3. On-Resistance vs. Drain Current and Gate Voltage

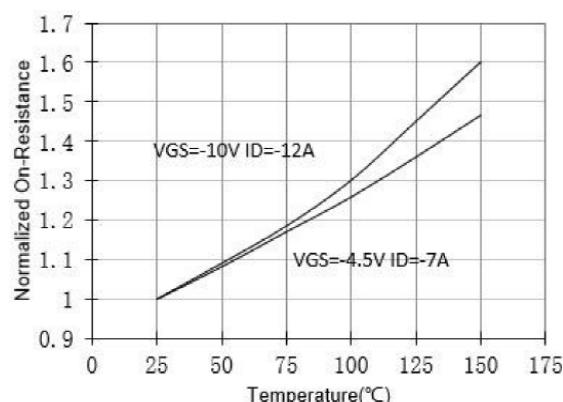


Figure 4. On-Resistance vs. Junction Temperature

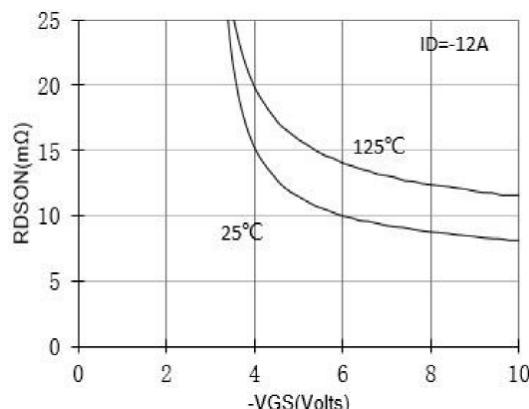


Figure 5. On-Resistance vs. Gate-Source Voltage

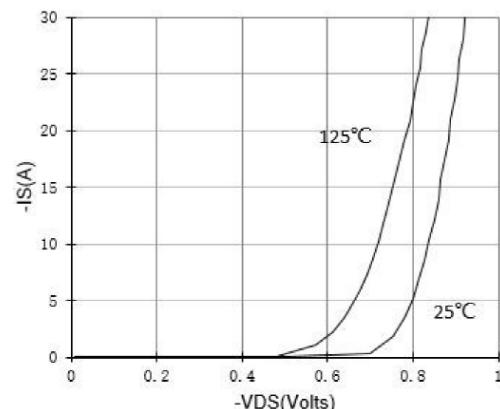


Figure 6. Body-Diode Characteristics

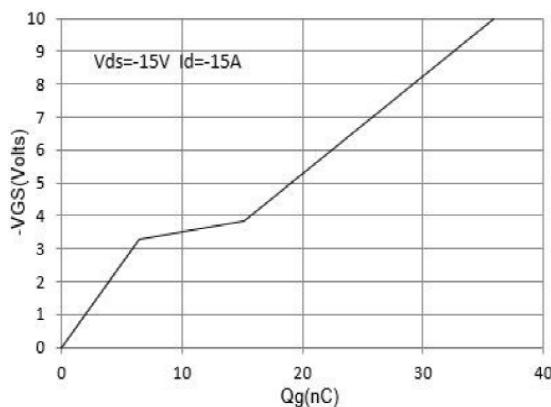


Figure 7. Gate-Charge Characteristics

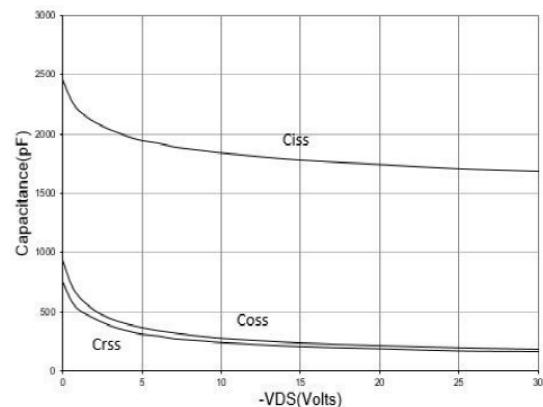


Figure 8. Capacitance Characteristics

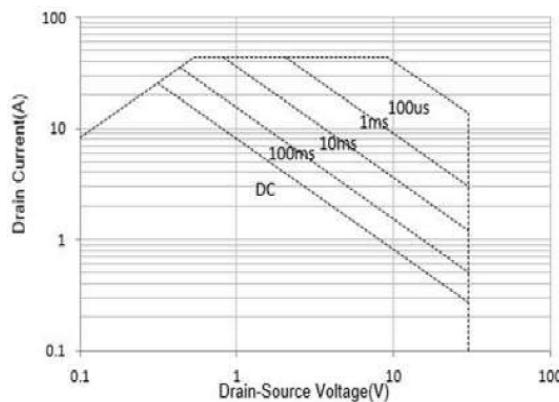


Figure 9. Maximum Forward Biased Safe Operating Area

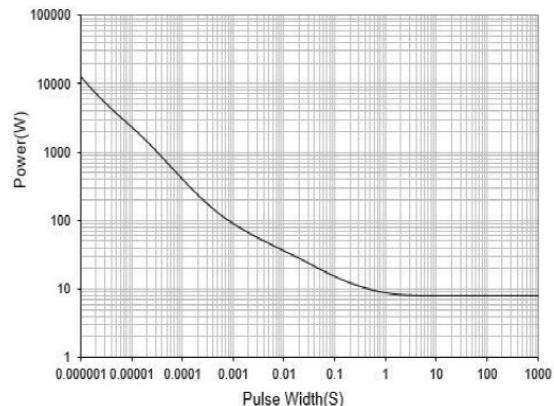


Figure 10. Single Pulse Power Rating Junction-to-Ambient

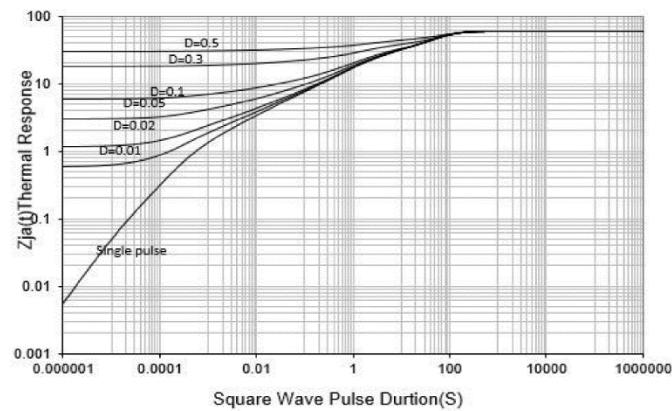


Figure 11. Normalized Maximum Transient Thermal Impedance